

DATA SHEET

74F191

Up/down binary counter with reset and ripple clock

Product specification

1995 Jul 17

IC15 Data Handbook

Up/Down binary counter with reset and ripple clock

74F191

FEATURES

- High speed –125MHz typical f_{MAX}
- Synchronous, reversible counting
- 4-Bit binary
- Asynchronous parallel load capability
- Cascadable without external logic
- Single up/down control input

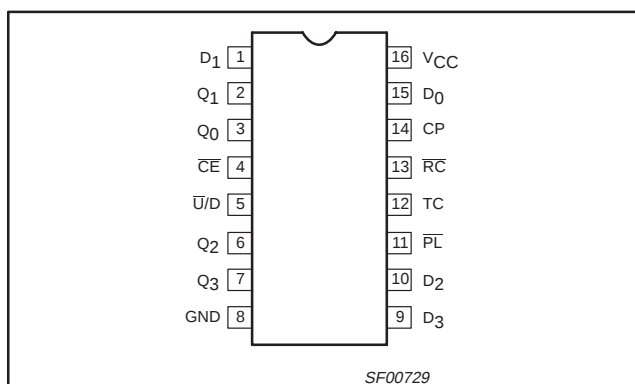
DESCRIPTION

The 74F191 is a 4-bit binary counter. It contains four edge-triggered master/slave flip-flops with internal gating and steering logic to provide asynchronous preset and synchronous count-up and count-down operations.

Asynchronous parallel load capability permits the counter to be preset to any desired number. Information present on the parallel data inputs ($D_0 - D_3$) is loaded into the counter and appears on the outputs when the Parallel Load ($\overline{PL}$) input is Low. This operation overrides the counting function. Counting is inhibited by a High level on the count enable ($\overline{CE}$) input. When $\overline{CE}$ is Low, internal state changes are initiated. Overflow/underflow indications are provided by two types of outputs, the Terminal Count (TC) and Ripple Clock ($\overline{RC}$).

The TC output is normally Low and goes High when: 1) the count reaches zero in the countdown mode or 2) reaches "15" in the count up mode. The TC output will remain High until a state change occurs, either by counting or presetting, or until $\overline{UD}$ is changed. TC output should not be used as a clock signal because it is subject to decoding spikes. The TC signal is used internally to enable the $\overline{RC}$ output. When TC is High and $\overline{CE}$ is Low, the $\overline{RC}$ follows the clock pulse. The $\overline{RC}$ output essentially duplicates the Low clock pulse width, although delayed in time by two gate delays.

PIN CONFIGURATION



TYPE	TYPICAL f_{MAX}	TYPICAL SUPPLY CURRENT (TOTAL)
74F191	125MHz	40mA

ORDERING INFORMATION

DESCRIPTION	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$, $T_{amb} = 0^\circ C \text{ to } +70^\circ C$	PKG DWG #
16-pin plastic DIP	N74F191N	SOT38-4
16-pin plastic SO	N74F191D	SOT109-1

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

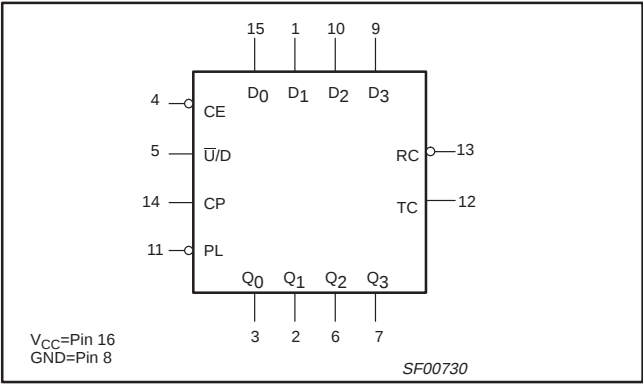
PINS	DESCRIPTION	74F(U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
$D_0 - D_3$	Data inputs	1.0/1.0	20 μ A/0.6mA
$\overline{CE}$	Count enable input (active Low)	1.0/3.0	20 μ A/1.8mA
CP	Clock pulse input (active rising edge)	1.0/1.0	20 μ A/0.6mA
$\overline{PL}$	Asynchronous parallel load control input (active Low)	1.0/1.0	20 μ A/0.6mA
$\overline{UD}$	Up/down count control input	1.0/1.0	20 μ A/0.6mA
$Q_0 - Q_3$	Flip-flop outputs	50/33	1.0mA/20mA
$\overline{RC}$	Ripple clock output (active low)	50/33	1.0mA/20mA
TC	Terminal count output	50/33	1.0mA/20mA

NOTE: One (1.0) FAST Unit Load (U.L.) is defined as: 20 μ A in the High state and 0.6mA in the Low state.

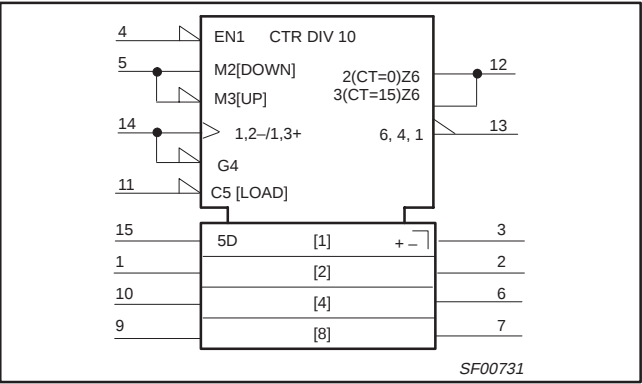
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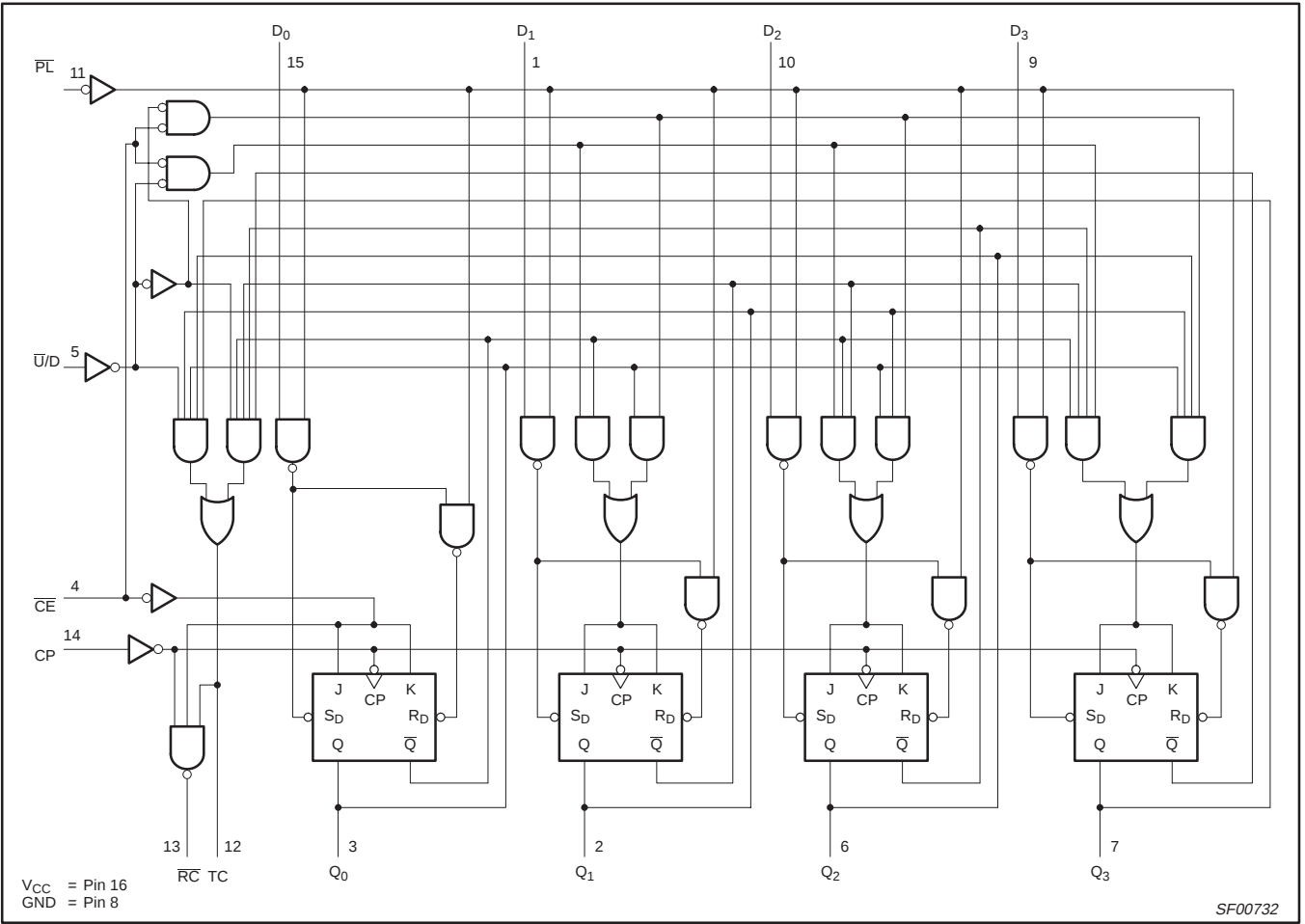
LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



LOGIC DIAGRAM



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MODE SELECT — FUNCTION TABLE

INPUTS					OUTPUTS	OPERATING MODE
$\overline{PL}$	$\overline{U/D}$	$\overline{CE}$	CP	D_n	Q_n	
L	X	X	X	L	L	Parallel load
L	X	X	X	H	H	
H	L	L	↑	X	Count up	Count up
H	H	L	↑	X	Count down	Count down
H	X	H	X	X	No change	Hold (do nothing)

TC AND $\overline{RC}$ FUNCTION TABLE

INPUTS			TERMINAL COUNT STATE				OUTPUTS	
$\overline{U/D}$	$\overline{CE}$	CP	Q_0	Q_1	Q_2	Q_3	TC	$\overline{RC}$
H	H	X	H	H	H	H	L	H
L	H	X	H	H	H	H	H	H
L	L	⌊	H	H	H	H	H	⌊
L	H	X	L	L	L	L	L	H
H	H	X	L	L	L	L	H	H
H	L	⌊	L	L	L	L	H	⌊

H = High voltage level steady state

L = Low voltage level steady state

X = Don't care

⌊ = Low pulse

↑ = Low-to-High clock transition

L = Low voltage level one set-up time prior to the Low-to-High clock transition

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APPLICATIONS

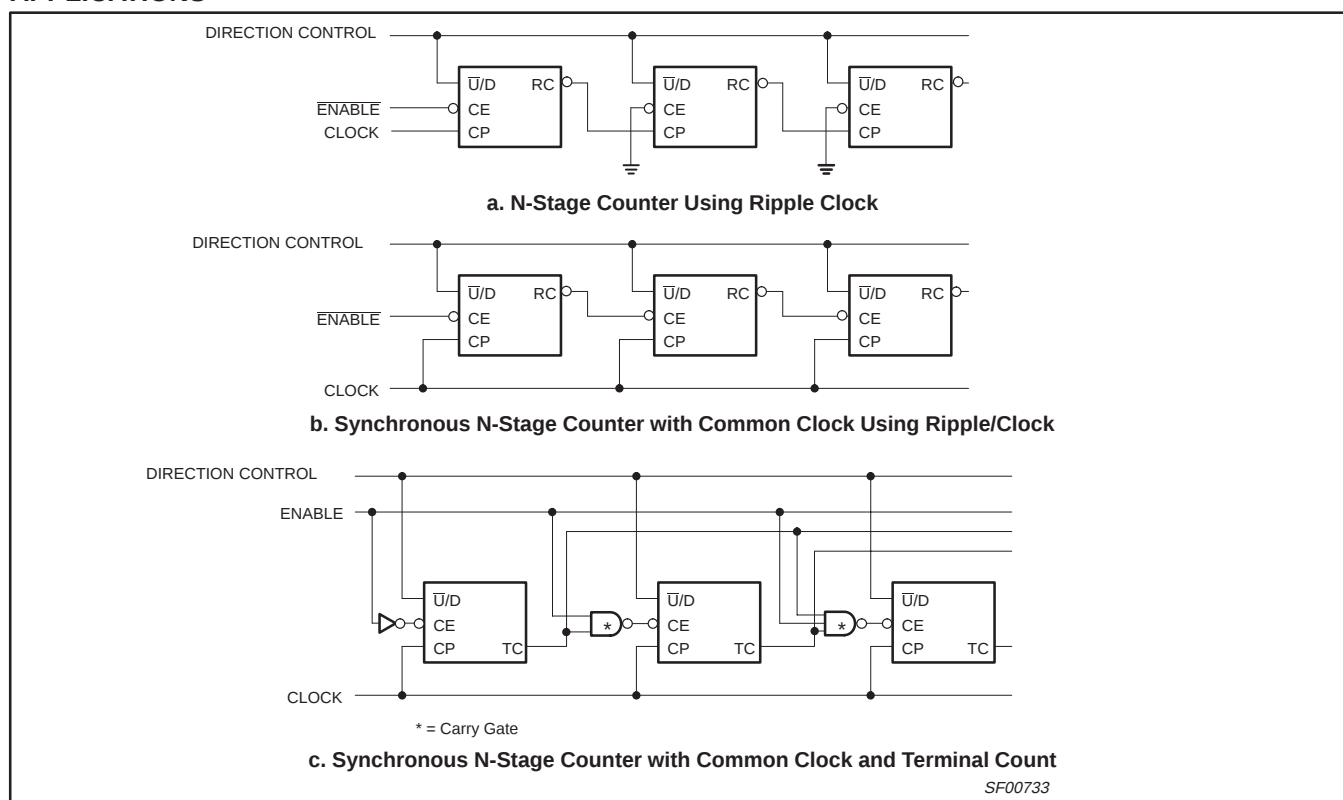


Figure 1.

The 74F191 simplifies the design of multi-stage counters, as indicated in Figure 1, each $\overline{RC}$ output is used as the clock input for the next higher stage. When the clock source has a limited drive capability this configuration is particularly advantageous, since the clock source drives only the first stage. It is only necessary to inhibit the first stage to prevent counting in all stages, since a High signal on $\overline{CE}$ inhibits the $\overline{RC}$ output pulse as indicated in the Mode Select Table. The timing skew between state changes in the first and last stages is represented by the cumulative delay of the clock as it ripples through the preceding stages. This is a disadvantage of the configuration in some applications.

Figure 1b shows a method of causing state changes to occur simultaneously in all stages. The $\overline{RC}$ output signals propagate in

ripple fashion and all clock inputs are driven in parallel. The Low state duration of the clock in this configuration must be long enough to allow the negative-going edge of the $\overline{RC}$ signal to ripple through to the last stage before the clock goes High. Since the $\overline{RC}$ output of any package goes High shortly after its clock input goes High, there is no such restriction on the High state duration of the clock.

In Figure 1c, the configuration shown avoids ripple delays and their associated restrictions. The combined TC signals from all the preceding stages forms the $\overline{CE}$ input signal for a given stage. An enable signal must also be included in each carry gate in order to inhibit counting. The TC output of a given stage is not affected by its own $\overline{CE}$, therefore, the simple inhibit scheme of Figure 1a and 1b does not apply.

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ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device.
Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V_{CC}	Supply voltage	-0.5 to +7.0	V
V_{IN}	Input voltage	-0.5 to +7.0	V
I_{IN}	Input current	-30 to +5.0	mA
V_{OUT}	Voltage applied to output in High output state	-0.5 to + V_{CC}	V
I_{OUT}	Current applied to output in Low output state	40	mA
T_{amb}	Operating free-air temperature range	0 to +70	°C
T_{stg}	Storage temperature	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS			UNIT
		Min	Nom	Max	
V_{CC}	Supply voltage	4.5	5.0	5.5	V
V_{IH}	High-level input voltage	2.0			V
V_{IL}	Low-level input voltage			0.8	V
I_{IK}	Input clamp current			-18	mA
I_{OH}	High-level output current			-1	mA
I_{OL}	Low-level output current			20	mA
T_{amb}	Operating free-air temperature range	0		70	°C

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER		TEST CONDITIONS ¹		LIMITS			UNIT
					Min	Typ ²	Max	
V _{OH}	High-level output voltage		V _{CC} = Min, V _{IL} = Max, I _{OH} = Max, V _{IH} = Min	±10%V _{CC}	2.5			V
				±5%V _{CC}	2.7	3.4		V
V _{OL}	Low-level output voltage		V _{CC} = Min, V _{IL} = Max, I _{OL} = Max, V _{IH} = Min	±10%V _{CC}		0.30	0.50	V
				±5%V _{CC}		0.30	0.50	V
V _{IK}	Input clamp voltage		V _{CC} = Min, I _I = I _{IK}			−0.73	−1.2	V
I _I	Input current at maximum input voltage		V _{CC} = Max, V _I = 7.0V				100	μA
I _{IH}	High-level input current		V _{CC} = Max, V _I = 2.7V				20	μA
I _{IL}	Low-level input current	CE	V _{CC} = Max, V _I = 0.5V				−1.8	mA
		Others					−0.6	mA
I _{OS}	Short-circuit output current ³		V _{CC} = Max		−60		−150	mA
I _{CC}	Supply current ⁴ (total)		V _{CC} = Max			40	55	mA

NOTES:

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^\circ\text{C}$.
- Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.
- Measure I_{CC} all inputs grounded and all outputs open.

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AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			T _{amb} = +25°C V _{CC} = +5.0V C _L = 50pF, R _L = 500Ω			T _{amb} = 0°C to +70°C V _{CC} = +5.0V ± 10% C _L = 50pF, R _L = 500Ω		
			Min	Typ	Max	Min	Max	
f _{MAX}	Maximum clock frequency to Q _n outputs	Waveform 1	100	125		90		MHz
f _{MAX}	Maximum clock frequency to RC outputs	Waveform 1	85	95		75		MHz
t _{PLH} t _{PHL}	Propagation delay CP to Q _n	Waveform 1	2.5 5.0	4.5 7.5	8.0 11.5	2.0 5.0	8.5 12.0	ns ns
t _{PLH} t _{PHL}	Propagation delay CP to TC	Waveform 1	6.5 6.0	9.0 8.0	12.5 11.0	6.0 6.0	13.0 12.0	ns ns
t _{PLH} t _{PHL}	Propagation delay CP to RC	Waveform 2	2.5 3.0	4.5 5.0	7.5 7.5	2.0 2.5	8.0 8.0	ns ns
t _{PLH} t _{PHL}	Propagation delay CE to RC	Waveform 2	2.0 3.0	4.0 5.0	7.0 7.5	2.0 3.0	7.5 8.0	ns ns
t _{PLH} t _{PHL}	Propagation delay U/D to RC	Waveform 2	8.0 4.5	11.0 7.5	16.0 10.5	8.0 4.0	17.0 11.0	ns ns
t _{PLH} t _{PHL}	Propagation delay U/D to TC	Waveform 4	4.0 3.0	6.5 6.0	9.5 9.5	3.0 3.0	10.5 10.0	ns ns
t _{PLH} t _{PHL}	Propagation delay D _n to Q _n	Waveform 3	2.0 6.5	4.0 9.0	7.0 12.0	1.5 6.5	7.5 13.0	ns ns
t _{PLH} t _{PHL}	Propagation delay D _n to TC	Waveform 3 Waveform 4	5.5 6.5	9.5 9.5	13.0 13.0	5.0 6.0	14.0 14.0	ns ns
t _{PLH} t _{PHL}	Propagation delay D _n to RC	Waveform 3 Waveform 4	6.0 6.0	14.0 11.0	18.0 13.5	6.0 6.0	19.5 15.0	ns ns
t _{PLH} t _{PHL}	Propagation delay PL to Q _n	Waveform 5	4.5 5.5	6.5 8.0	9.5 11.5	4.0 5.0	10.5 12.0	ns ns
t _{PLH} t _{PHL}	Propagation delay PL to TC	Waveform 5	5.5 6.0	8.5 10.5	12.0 13.5	5.5 6.0	13.0 14.5	ns ns
t _{PLH} t _{PHL}	Propagation delay PL to RC	Waveform 5	8.5 7.5	16.0 10.0	18.5 13.0	8.5 7.0	21.0 13.5	ns ns

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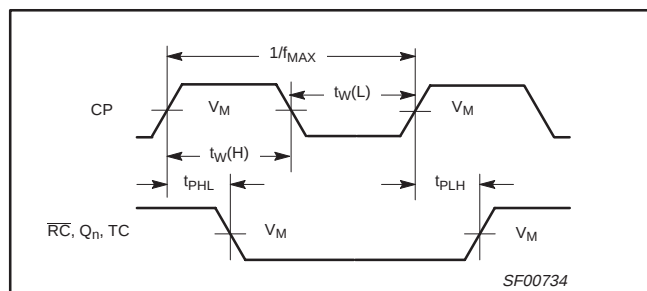
AC SETUP REQUIREMENTS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			T _{amb} = +25°C V _{CC} = +5.0V C _L = 50pF, R _L = 500Ω			T _{amb} = 0°C to +70°C V _{CC} = +5.0V ± 10% C _L = 50pF, R _L = 500Ω		
			Min	Typ	Max	Min	Max	
t _s (H) t _s (L)	Setup time, High or Low D _n to $\overline{PL}$	Waveform 6	4.5 4.5			5.0 5.0		ns ns
t _h (H) t _h (L)	Hold time, High or Low D _n to $\overline{PL}$	Waveform 6	2.0 2.0			2.0 2.0		ns ns
t _s (L)	Setup time, Low $\overline{CE}$ to CP	Waveform 6	10.0			10.0		ns
t _h (L)	Hold time, Low $\overline{CE}$ to CP	Waveform 6	0			0		ns
t _s (H) t _s (L)	Setup time, High or Low $\overline{U/D}$ to CP	Waveform 6	12.0 12.0			12.0 12.0		ns ns
t _h (H) t _h (L)	Hold time, High or Low $\overline{U/D}$ to CP	Waveform 6	0 0			0 0		ns ns
t _w (H) t _w (L)	CP Pulse width, High or Low	Waveform 1	3.5 6.0			3.5 6.0		ns ns
t _w (L)	$\overline{PL}$ Pulse width, Low	Waveform 5	6.0			6.0		ns
t _{rec}	Recovery time, $\overline{PL}$ to CP	Waveform 5	6.0			6.0		ns

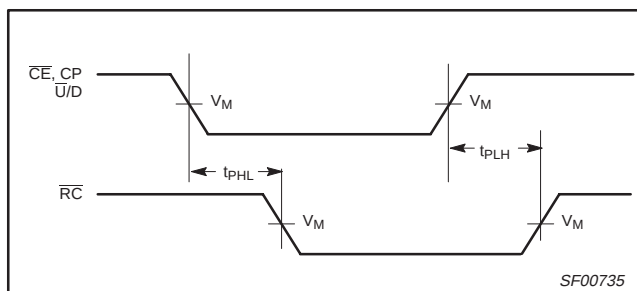
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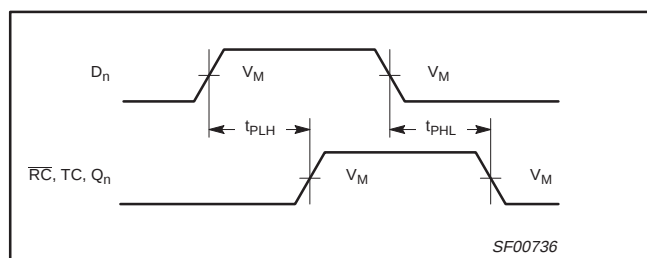
AC WAVEFORMS

NOTE: For all waveforms, $V_M = 1.5V$ 

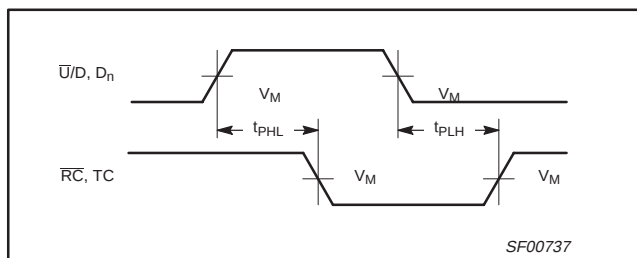
Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency.



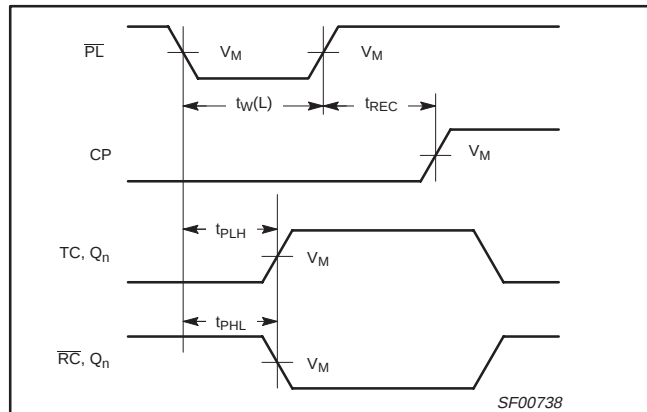
Waveform 2. Propagation Delay, Clock, Clock Enable or Up/Down to Ripple Clock Output



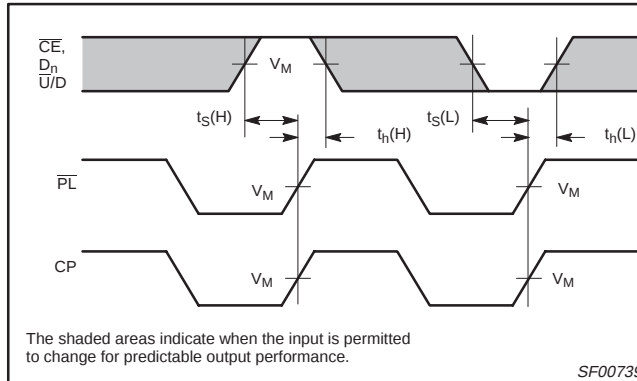
Waveform 3. Propagation Delay, Non-Inverting Path



Waveform 4. Propagation Delay, Inverting Path



Waveform 5. Parallel Load Pulse Width, Parallel Load to Output Delay and Parallel Load to Clock Recovery Time

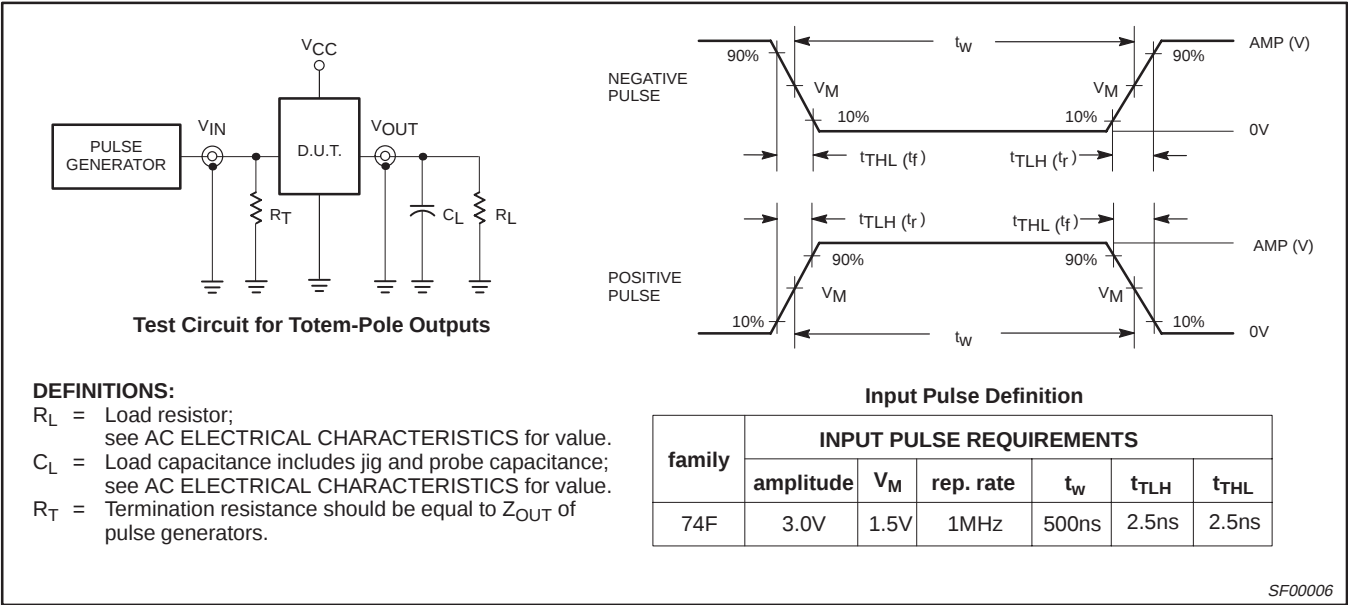


Waveform 6. Data Set Up and Hold Times

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TEST CIRCUIT AND WAVEFORM

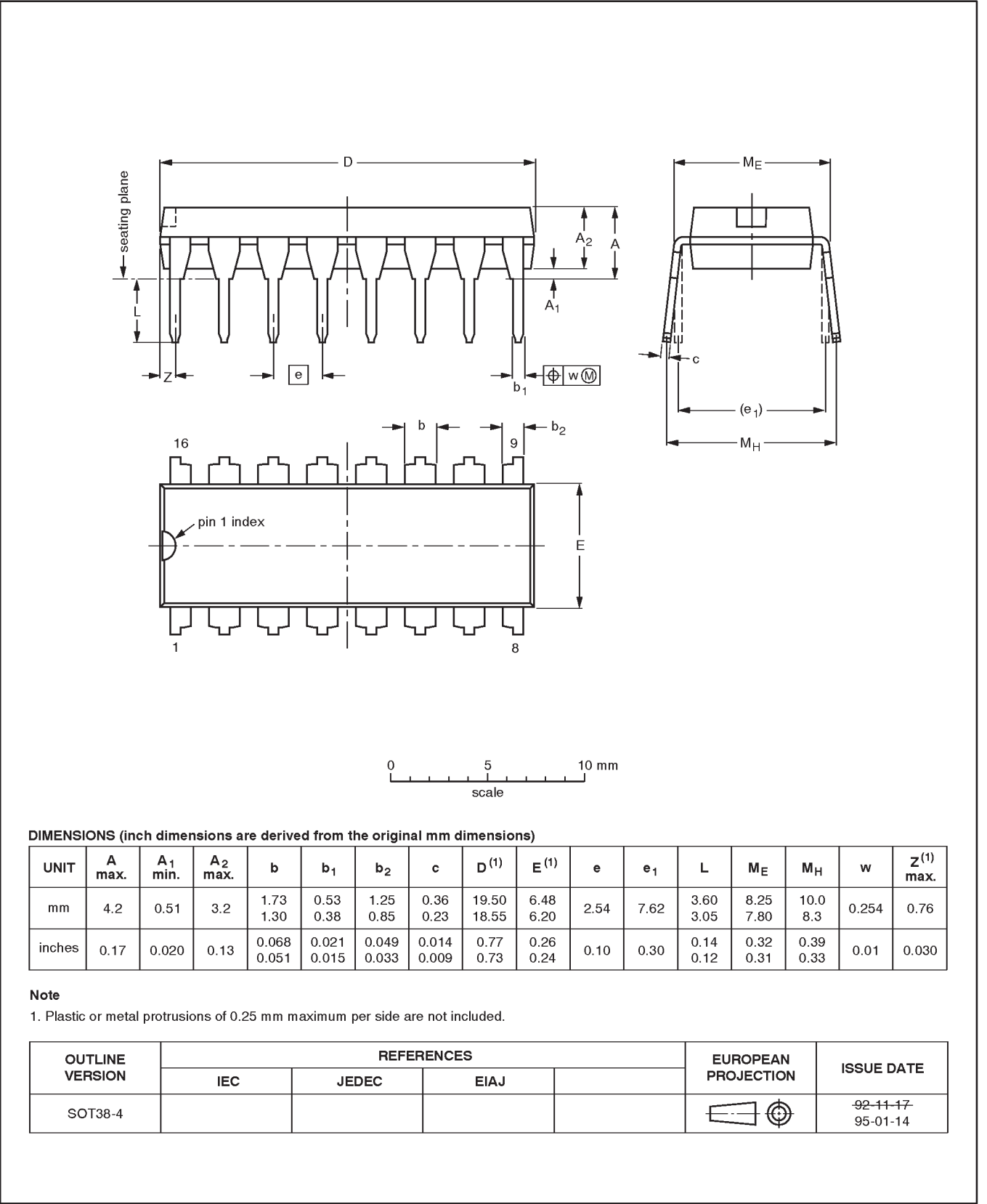


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DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4

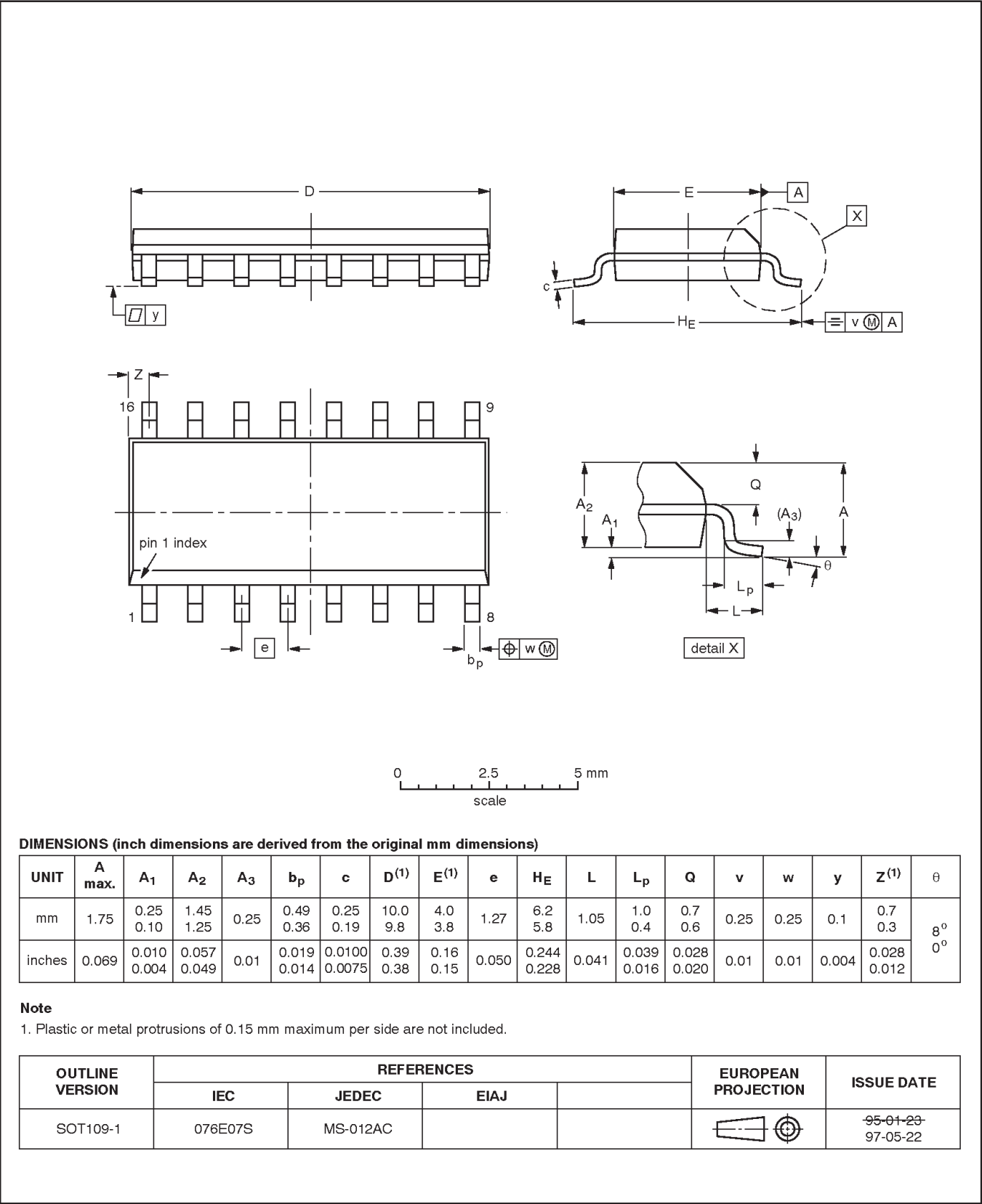


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SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



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NOTES

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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